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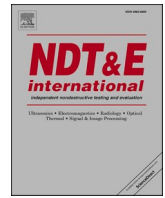


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Analyzing efficiency of optical and THz infrared thermography in nondestructive testing of GFRPs by using the Tanimoto criterion

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ABSTRACT

This study has illustrated the potentials of optical and THz infrared thermography in the identification of inserts of different nature in glass fiber reinforced polymer. The inspection efficiency has been comparatively evaluated by applying the Tanimoto criterion. The best test procedure has proven to be one-sided stationary thermal nondestructive testing (TNDT) implementing optical heating with Xenon lamps (Tanimoto criterion 87%). Close values of the Tanimoto criterion have been achieved by using the optical and THz line-scanning procedures. A more subjective evaluation of test procedures has been performed by comparing eight parameters of test performance. The line-scanning TNDT procedure implementing optical heating with halogen lamps seems to be optimal in practical applications.

1. Introduction

Techniques of nondestructive testing involve the analysis of some physical processes occurring in solids as a result of applied thermal stimulation [1–4]. The presence of hidden defects causes variations of a basic signal ΔS , and from the theoretical point of view an optimal nondestructive testing (NDT) method should provide a maximum signal-to-noise ratio (SNR) $\Delta S/\sigma_S$, where σ_S is the standard deviation of the signal constituting noise of different nature. From the practical point of view, the optimization of test procedures involves many other parameters, such as inspection rate, automation potentials, safety issues, etc. The use of the SNR concept is ubiquitous in NDT, but it is weakly related to visual perception of images formed by some NDT techniques. Therefore, some other comparison parameters have been proposed, such as the Tanimoto criterion [5–7].

In this study, we compare results of infrared (IR) thermographic and TeraHertz (THz) NDT of glass fiber reinforced plastic (GFRP) by using the Tanimoto criterion and analyzing heuristically some other characteristics of inspection performance. Our start point is that IR thermography is the acknowledged technique for detecting and evaluating discontinuities in GFRP in a one-sided test procedure [8–14], while the THz method is a promising newcomer in the field of NDT of composites

[15–18]. The comparison of these two methods is of interest in the aviation and aerospace industry where composites are successfully replacing metals.

2. Test sample

The $195 \times 195 \times 9 \text{ mm}^3$ test sample made of GFRP contained 12 artificial defects with lateral size 10×10 and $20 \times 20 \text{ mm}^2$ incorporated during sample manufacturing (see the photo of the sample and the scheme of defect location in Fig. 1). Defects were open air slits (D1–D4), foam inserts (D5, D7, D10, D12), epoxy resin inserts (D6, D8) and internal air gaps (D9, D11) located at the depths of 6.16 (D1, D4, D5, D6, D9, D12) and 4.95 mm (D2, D3, D7, D8, D10, D11). The thickness of all inserts was 0.64 mm. The sample was painted with the acrylic black dye in order to increase the absorption coefficient up to 0.96 and diminish GFRP optical semi-transparence (the latter phenomenon might be essential when applying optical heating).

The reference sample has been supposed to simulate some typical defects which might appear in GFRP in manufacture and operation. However, it is worth noting that development of trust-worthy reference samples deserves a special investigation. Independently on a testing technique, defects of the same nature and size produce similar but not

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identical signals because of a spread in planned defect parameters, in particular, if a resin is used in producing defects. This makes development of reference samples difficult.

3. Infrared thermography

The reference sample described above was tested by applying a couple of IR thermographic inspection techniques, namely, classical one- and two-sided “stationary” procedures using 2 kW halogen (Fig. 2a) and 2.2 kJ Xenon flash tubes (Fig. 2b), as well as a scanning procedure involving a 2 kW linear heater (Fig. 2c). Temperature distributions on the sample surface were recorded by using an Optris Pi450 (382 × 288, 7–13 μm) and FLIR SCX6900 (640 × 512, 7–13 μm) IR imagers.

Results of one- and two-sided IR thermographic tests are presented in Fig. 3. The sample was exposed to optical heating for 10 and 20 s (in one- and two-sided test procedures), with the distance between the heater and the sample being 0.4 m, and acquisition frequency - 10 Hz. Note that, in one-sided procedures, the sample was tested on both front and rear sample surfaces. Test results were processed by applying the techniques of Principle Component Analysis (PCA) and Thermographic Signal Reconstruction (TSR) [19–25].

The one-sided test procedure applied to the front surface (A) allowed to detect all defects except the defect D1. Oppositely, the results obtained in the rear-surface test clearly showed the defect D1, which was the closest to the rear surface (B). By applying the two-sided test, one was able to detect all defects, however, the defects #6 and #8 (epoxy resin inserts) were characterized by fairly weak signals.

The better results were demonstrated by having applied the line-scanning procedure of thermal NDT (TNDT), Fig. 4, probably, due to a higher heating power and a more uniform heating pattern to compare to the stationary procedures. After having the sample passed the heating zone, its surface temperature was recorded at the cooling stage within the time period from 20 to 85 s by using two Optris IP450 IR cameras placed opposite to each other. Note that test parameters, such as the movement speed (5 mm/s), acquisition frame rate (5.8 Hz) and the width of a single scanned line (1.09 pixel/mm) have been carefully chosen to ensure the synthesis of resulting IR images without under- and overlapping of scanned lines. One more test was performed by reducing the heating time up to 5 s and respectively increasing the movement speed up to 10 mm/s (the frame rate was adjusted to 11.6 Hz). The corresponding test results are presented in Fig. 4c and d.

Fig. 5 shows the results obtained by applying the flash test procedure (two 2.2. kJ Xenon flash tubes). The temperature distributions were recorded by means of a FLIR x6900sc IR imager for 200 s with the acquisition rate of 50 Hz. The best results have been achieved by analyzing IR image sequences within particular time intervals representing best observation times by the parameter of temperature contrast

$C = \Delta T / T_{nd}$, where ΔT is the differential temperature signal in a defect area, and T_{nd} is the reference non-defect temperature (see Fig. 5a). The evolutions of the contrast have shown that the best observation times are from 20 to 100 s, and the most defects are characterized by the “classical” behavior of ΔT and C : the temperature signals over low-conductive defects reach maximums at particular times and then drop down. Oppositely, the defects D10 and D12 produced negative temperature signals and contrasts but of lower amplitudes (see the curves for D10 and D12 in Fig. 5a). Obviously, higher temperature signals appear over larger defects or those of whose thermal resistance strongly differs from the host material. To process IR images by applying the PCA technique, the 40–100 s interval has been used to enhance the visibility of the defects characterized by weak temperature signals.

The PCA approach has allowed identifying from 9 to 12 defects depending on a surface tested and a chosen PCA component. Similar results were obtained by using the TSR technique (Fig. 6).

The characterization of defect depth h [m] and thermal resistance $R_d = d/K_d$, where d is the defect thickness [m], and K_d is the defect conductivity [$Wm^{-1} \cdot K^{-1}$], has been performed by using the inversion formulas obtained by solving a problem of heat conduction in a three-layer plate subjected to square-pulse heating. These formulas involve polynomial functions including experimental parameters [26]:

$$h [m] = 0.708 \left[a(\tau_m - \tau_h) \right]^{0.456} \left(1 - \frac{K_d}{K} \right)^{0.285} \left(\frac{L}{K} \right)^{0.0536} Fo_h^{0.0523} C^{-0.151},$$

$$R_d [m^2 KW^{-1}] = 4.368 \left[a(\tau_m - \tau_h) \right]^{0.343} \left(1 - \frac{K_d}{K} \right)^{1.265} \left(\frac{L}{K} \right)^{0.286} Fo_h^{-0.0530} C^{0.426}.$$
(1)

Here $a [m^2 s^{-1}]$ is the material thermal diffusivity of the material, $\tau_m [s]$ is the best observation time for a particular defect, $\tau_h [s]$ is the heating time, $L [m]$ is the sample thickness, $K [Wm^{-1}K^{-1}]$ is the material thermal conductivity, $Fo_h = a\tau_h L^{-2}$ is the dimensionless Fourier number, and C is the dimensionless running temperature contrast. The inversion formulas above could be precised for a narrower range of materials by choosing more carefully the numerical coefficients. The practical experience of using these equations has shown that the accuracy in determining h is about 15–30% for different types of composites, while for R_d the accuracy drops down to 40–60%. The characterization algorithm described above is simple and robust allowing producing images of defect depth (“depthgrams”) and thermal resistance. It should be also noted that the applied algorithm and formula were derived for air-filled defects, therefore, their validity in application to resin- and foam-filled defects is questionable.

To apply Eq. (1), each sequence of raw IR images was converted into the corresponding sequence of images representing evolution of contrast C . An example of choosing a reference area for determining C is

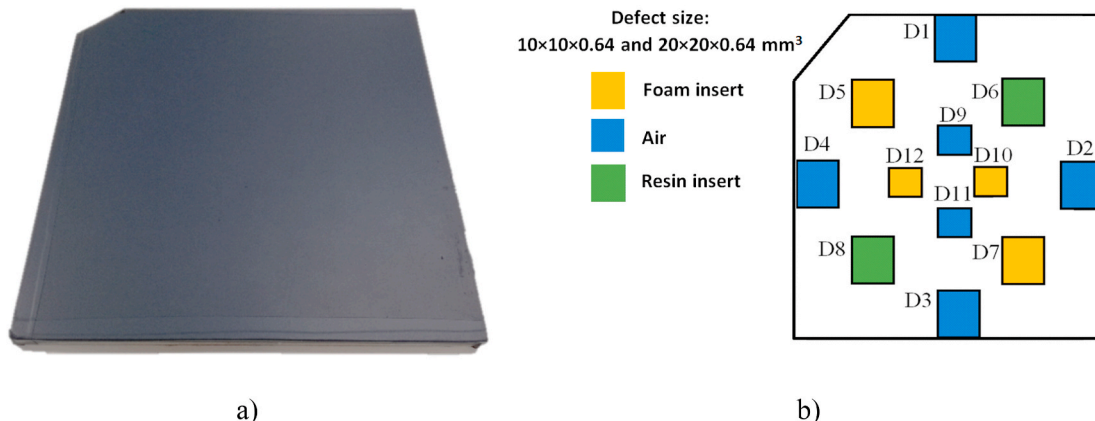


Fig. 1. Photo of black-painted test sample (a) and scheme of defects (b).

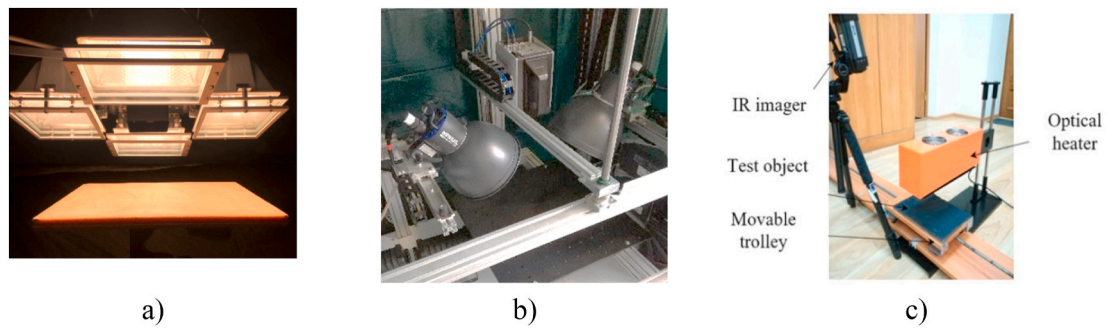


Fig. 2. Experimental IR thermographic setups with halogen lamps (a), Xenon flash tubes (b) and line-scanning implementation (c).

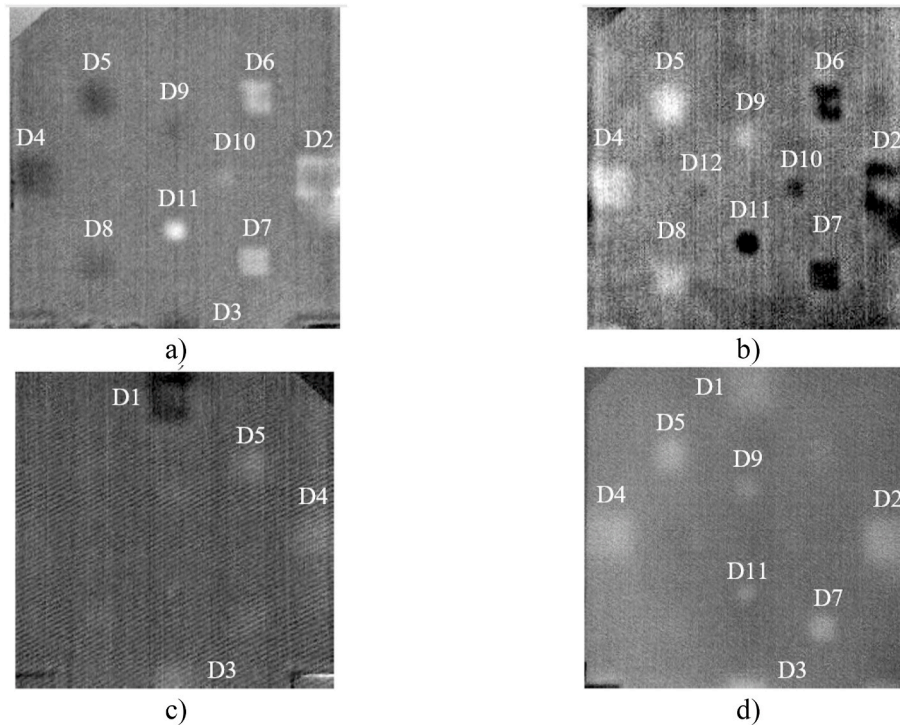


Fig. 3. Results of applying one- and two-sided test procedures (optical heating with 2 kW halogen lamps for 10 s (a–c) and 20 s (d): a – one-sided procedure, front surface (A), PCA image, 3rd component, b - one-sided procedure, front surface (A), TSR image, 1st derivative; c - one-sided procedure, rear surface (B), PCA image, 3rd component, d - two-sided procedure, front surface (A), PCA image, 1st component.

indicated in red in Fig. 5b. Next, the C -sequences were processed to calculate the images of the maximum running contrast C_m (maxigrams) and the images of the best observation time τ_m (timegrams), as shown in Fig. 7 a, b for the subsequent calculation of h and R_d . Note that Eq. (1) is valid if C_m values occur after the heat pulse, i.e. $\tau_m > \tau_h$.

The depthgram in Fig. 7c shows the depths of particular defects. The accuracy of evaluated values from 6 to 20% was confirmed by measuring depth of open air slits #1, 2 and 4 (defect #3 was not evaluated because of the high thermal noise caused by a surface sticker).

The image of defect thermal resistance in Fig. 7d shows all defects in more or less the same color, however, the defects #6 and #8 (resin inserts) have lower R_d value. The pixel values in the defect areas #2, 4, 5, 7, 9 and 11 correspond to $R_d \sim 0.015 \text{ m}^2 \text{ K} \cdot \text{W}^{-1}$, and for defects #6 and #8 $R_d \sim 0.032 \text{ m}^2 \text{ K} \cdot \text{W}^{-1}$. Respectively, the above-mentioned values produce the following estimates of defect thickness: $d = 8.5 \text{ mm}$ if to assume that air conductivity in thin gaps is $0.07 \text{ m}^2 \text{ K} \cdot \text{W}^{-1}$, and $d = 1.2 \text{ mm}$ if to assume that resin conductivity is $0.5 \text{ m}^2 \text{ K} \cdot \text{W}^{-1}$.

It is worth noting that the images in Fig. 7c and d have been produced with an amplitude threshold by C values of 10% and 25% respectively. This has allowed obtaining clear images of defect indications while the

non-defect areas were characterized by the constant values of $h = 9 \text{ mm}$ and $R_d = 0$ respectively.

To visually demonstrate how defects are located within the sample, the algorithm of dynamic thermal tomography (DTT) was applied (see Fig. 8) [27–33]. In fact, each thermal tomogram shows distribution of τ_m times in a particular interval (with the introduced threshold of 1.2% by τ_m). The DTT algorithm, like the defect characterization algorithm, requires selecting a reference point, and it is based on the analysis of the corresponding timegrams. By changing time intervals in a timegram, one can “slice” a test sample thanks to the fact that deeper layers are characterized by increasing time delays. Fig. 8a and b presents the layers (depth intervals) for two groups of defects: 1.5–3 mm with defects #2, 6, 7, 11, and 3–5 mm with defects #1, 3, 4, 5, 8, 9. Fig. 8 c-k illustrate the slicing of the sample with the depth step of 0.5 mm. Respectively, Fig. 8 (l) shows the reconstruction of the sample performed by using the DTT algorithm.

4. Terahertz imaging

The THz imaging of the sample was fulfilled by using the two

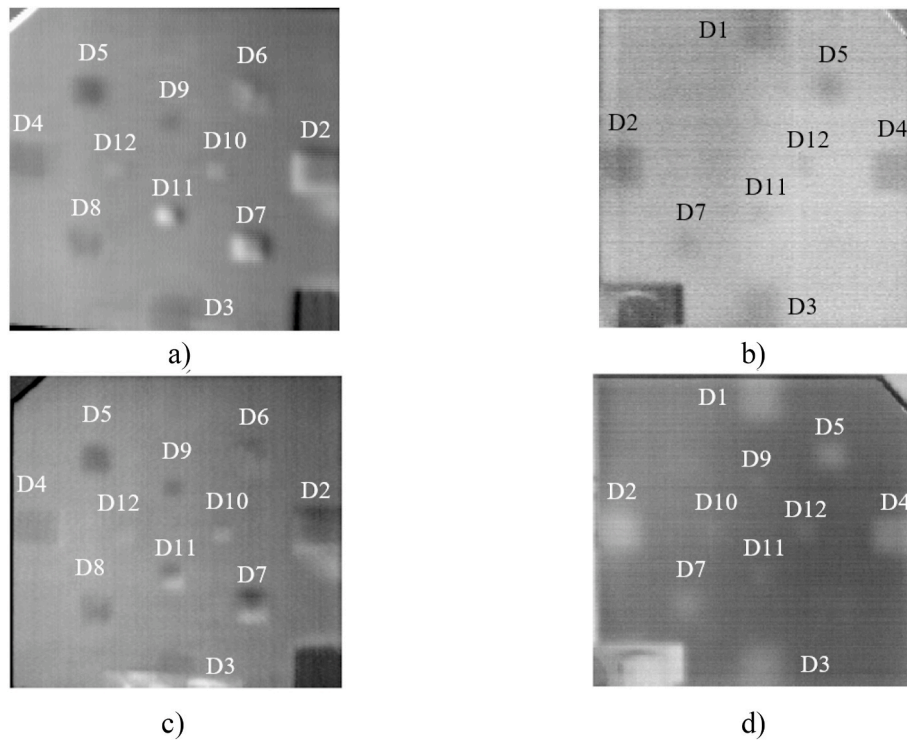


Fig. 4. Test results obtained by using the scanning TNDT procedure (PCA images): a– front surface (A), heating duration 10 s, movement speed 5 mm/s, frame rate 5.8 Hz, b – same as a), rear surface (B), c – front surface (A), heating duration 5 s, movement speed 10 mm/s, frame rate 12 Hz, d – same as c), rear surface (B).

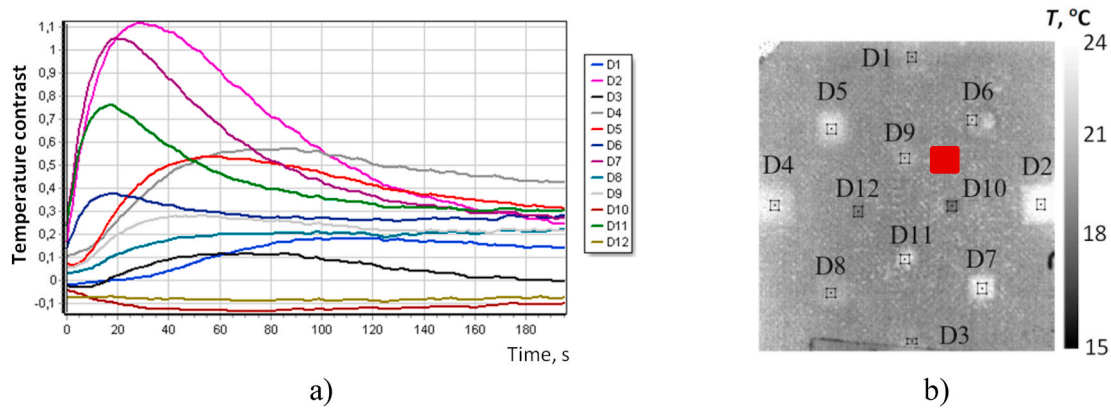


Fig. 5. Evolution of temperature contrast for defects D1-D12 (a) and example of the optimal source image at 60 s (b) (one-sided procedure, front surface A, flash heating).

techniques: imaging scanning (Fig. 9a) and line-scanning (Fig. 9b). Both techniques were implemented in the transmission (two-sided) mode.

In the imaging scanning procedure, a THz source based on a Gunn diode with the power of 400 mW and frequency of 110 GHz has been used. A set of Teflon lenses has been applied to focus the source beam into the spot with the diameter of 15 mm on the sample surface. To increase the SNR and image quality (spatial resolution and sensitivity), the scan of the sample was performed by a 3 × 3 mm grid using a two-coordinate linear-motion system, and all scanned points overlapped each other by 10%. The THz beam was partially absorbed while passing through the sample and totally absorbed by the Therathermal converter (TTC) [34,35]. The TTC temperature change was monitored with a FLIR SC7500 camera (frame rate 200 Hz, resolution 40 × 35 pixels). Note that each point on the sample surface was exposed to THz irradiation for 8 s including 8 periods of saturation and relaxation of the TTC. The optimum time for observing each point (8 s) was evaluated by modeling

absorption in a semitransparent body. During 7 of 8 periods, the temperature of the TTC reached stability, and temperature recording was performed in the 8th period. Fig. 10 explains the behavior of the TTC temperature signal during scanning.

At each scanned point, the temperature values were averaged in time by applying a moving filter. Some examples of resulting images are shown in Fig. 11.

It is important noting that the imaging scanning method took 12 h to scan the whole sample and allowed to detect from 8 to 10 defects depending on the processing procedure. It is interesting that some defects, such as #6, #8, #9 and #11, which are thin “inserts” of resin and air, can hardly be detected. This can be explained by the low difference in absorption coefficients of the inserts and sample material. The defects #5, #7, #10 and #12 which are inserts of foam are characterized by the transparency close to GFRP, but these defects can easily be detected due to clearly visible borders apparently filled with air. The defects #1–4

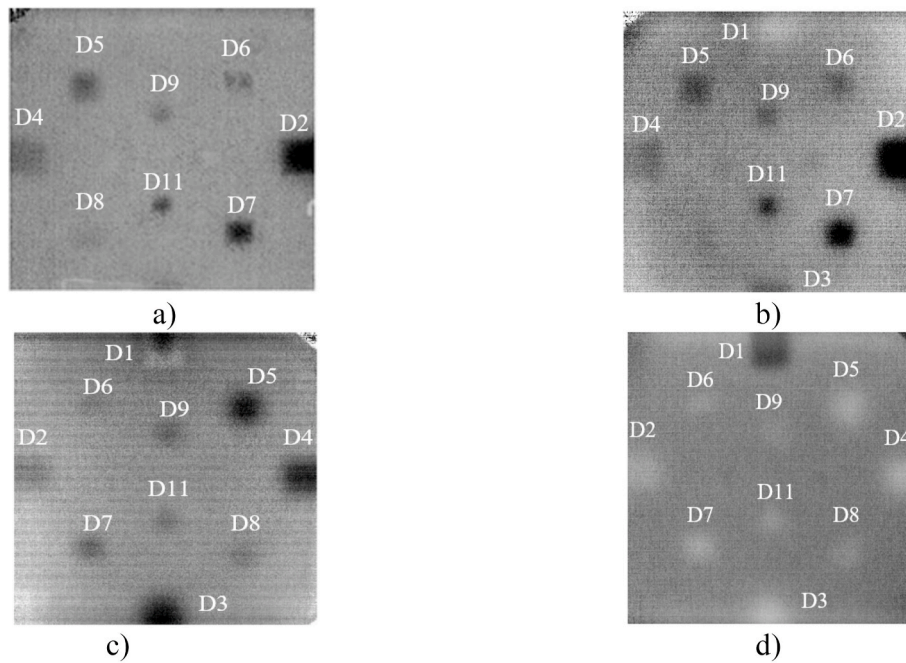


Fig. 6. Results obtained by using flash heating in one-sided (a, b) and two-sided (c, d) test procedures: a – front surface (A), PCA image, 1st component, b – front surface (A), TSR image, 1st derivative, c - rear surface (B), PCA image, 2nd component, d - rear surface (B), TSR image, 1st derivative.

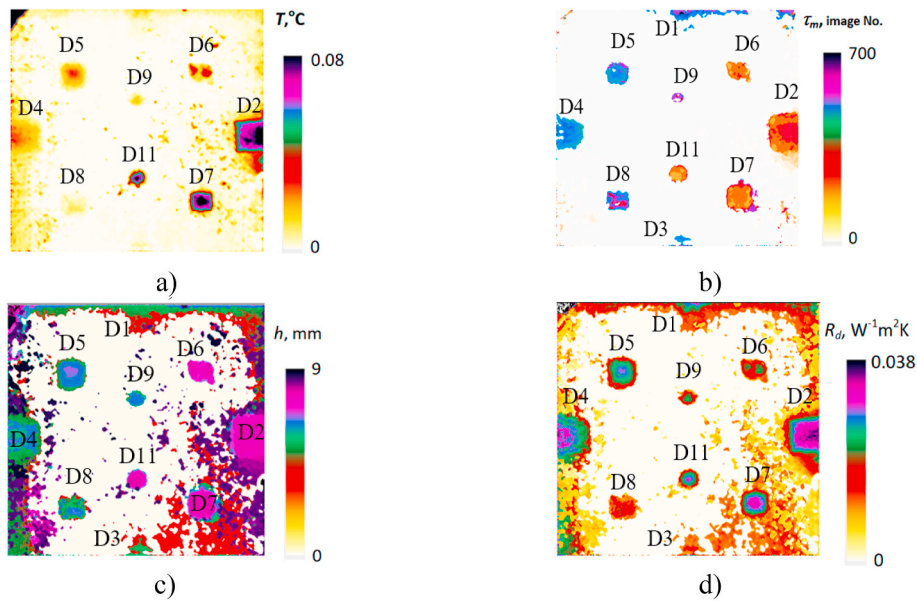


Fig. 7. Defect characterization by applying 1D inverse analytical approach: a - maxigram, b - timegram, c - depthgram, d - image of defect thermal resistance.

have lower absorption coefficient corresponding to air.

The results obtained by using the line-scanning method look less noisy and more sensitive to the structure of the sample, probably, due to a higher resolution of the transducer. The scanning was fulfilled by using a Terasense Sub-Thz imaging system. The sample was moving by means of a line-motion system with the speed of 15 mm/s. The system resolution along the detector direction was 0.68 pixel/mm, and in the perpendicular direction - 33 pixel/mm (THz pulse frequency 500 Hz), see the result of scanning in Fig. 12.

One more drawback of Terahertz NDT is the difficulty to evaluate defect depth in the transmission inspection mode, therefore, in this study, only defect detection potentials of Terahertz NDT have been compared with results of classical TNDT.

5. Evaluating inspection performance (Tanimoto criterion)

As mentioned above, visual perception of test results is undoubtedly important in IR thermography. For example, reference (defect free) areas are identified by the operator who is guided by a certain list of pattern recognition rules. In this study, the set of test images (Figs. 3b, 4c and 4d, 6b, 6d, 11a, 12) taken by the authors as optimal were analyzed by 10 respondents who were familiar with basic principles of TNDT but not with the particular reference sample. The images were supplied in a random orientation in order to reduce the influence of the surface marker on defect identification. IR thermographic results have been analyzed in the grey-tone palette while the THz images were presented in the palette called “Summer”. In fact, it has been shown elsewhere that

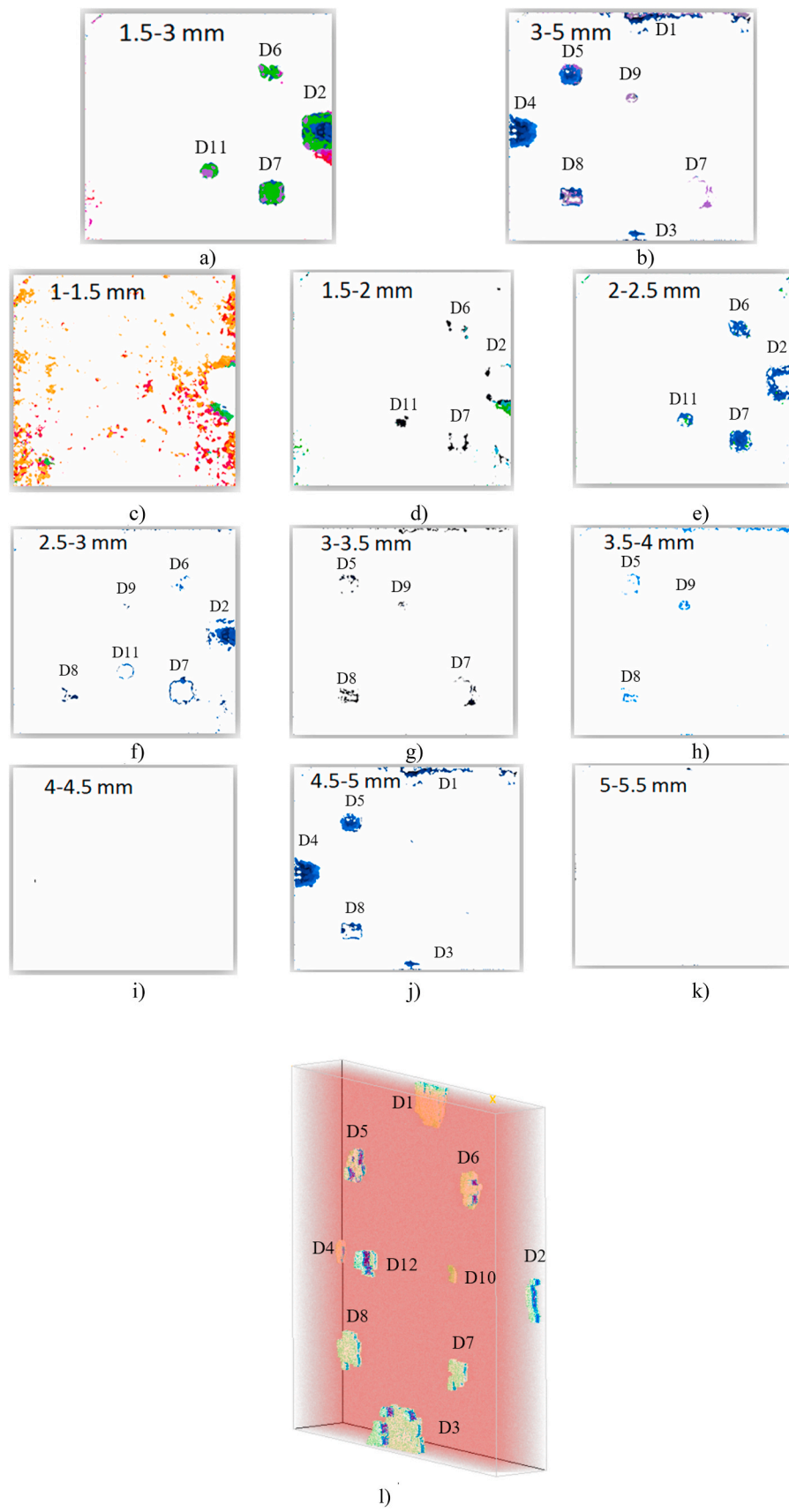


Fig. 8. Thermal tomography results: a – layer 1.5–3 mm, b – 3–5 mm, c – 1–1.5 mm, d – 1.5–2 mm, e – 2–2.5 mm, f – 2.5–3 mm, g – 3–3.5 mm, h – 3.5–4 mm, i – 4–4.5 mm, j – 4.5–5 mm, k – 5–6.5 mm, l – 3D reconstruction.

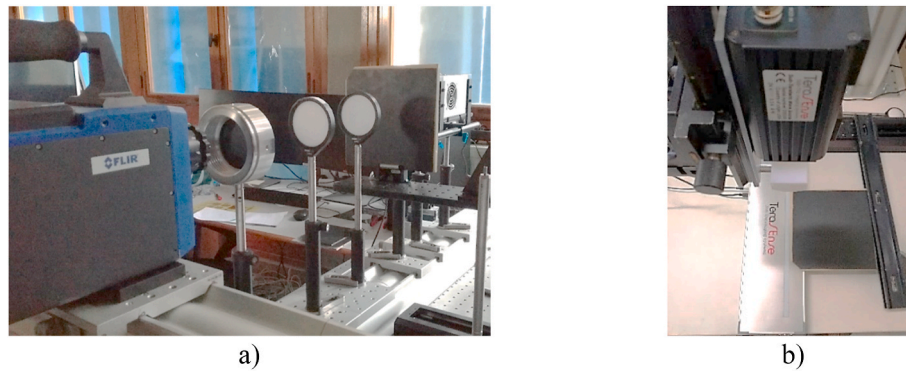


Fig. 9. Experimental setups for THz imaging in transmission mode: a – imaging scanning procedure, b – line-scanning procedure.

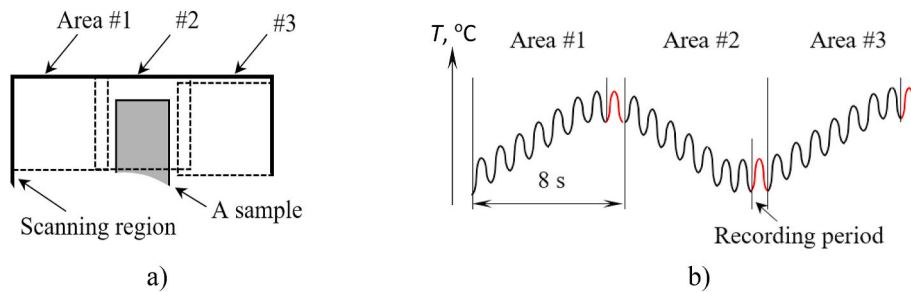


Fig. 10. Point-by-point scanning THz technique: a – scanning scheme, b – TTC temperature evolution (saturated THz signal).

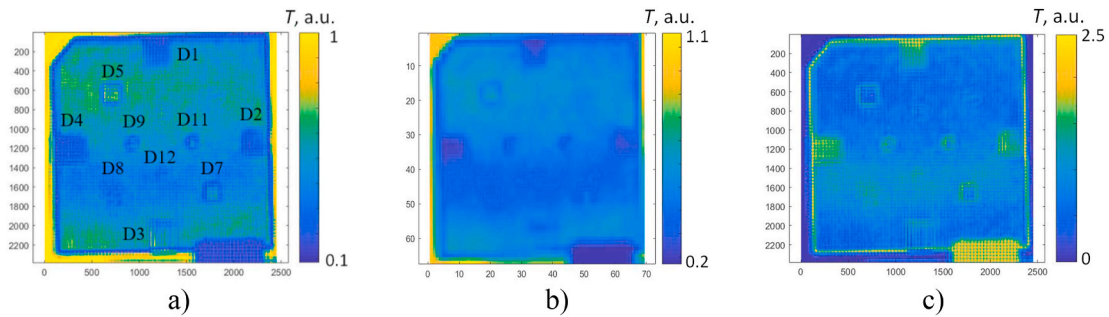


Fig. 11. Results of applying THz imaging scanning procedure in transmission mode: a – raw image, b – same as a), after 5×5 spatial averaging, c – same as a), in logarithmic scale.

the presentation of test results in different colors weakly influences on the interpretation of TNDT images [2].

Each respondent indicated the areas assumed to represent the defects, and this led to the appearance of some missed and false indications (see the examples of defect recognition in Fig. 13). The identification results were processed and averaged by 10 respondents by using the Tanimoto criterion [1]:

$$TC = \frac{N_{r.d.} - N_{m.d.}}{N_{r.d.} + N_{f.d.}}, \quad (2)$$

where $N_{r.d.}$, $N_{m.d.}$, $N_{f.d.}$ are the numbers of real, missed and false defects detected by an operator in the image analyzed ($N_{r.d.} = 12$ in this case). The interesting feature of the Tanimoto criterion is that it combines missed and false defects.

The TC values are presented in Table 1 to illustrate that, in general, the most efficient has been the TNDT procedure involving the TSR method of data processing (Fig. 6d) which provided $TC = 0.87$, while the lowest $TC = 0.72$ corresponded to the raw THz image (Fig. 11a). It is interesting to note that the lowest discrepancy in defect identification ($\sigma = 0.05$) was observed when the respondents analyzed the PCA images

obtained by applying optical heating for 5 s. Another remark of interest is that the analyzed test procedures have been characterized by the relatively low numbers of false defects, even if TNDT is typically considered as a fairly noisy inspection technique. In fact, the highest values of TC correlated well with the highest number of the defects correctly identified by the respondents.

However, the general performance of NDT techniques cannot be reduced to a single parameter, such as SNR or TC . A quantitative evaluation is difficult because the value of specific parameters in making correct defect determinations depends on inspection requirements, inspection purpose, etc., even though the most important parameter of NDT systems in some applications may be credibility. Table 2 evaluates the technical performance of several inspection techniques according to the following parameters: 1) value of the Tanimoto criterion; 2) inspection rate in $m^2 \text{ hr}^{-1}$; 3) ability to characterize defects (evaluating defect size and depth); 4) ability to detect an insert material (air, resin, foam, etc.); 5) minimum detectable defect size; 6) unit test area; 7) suitability for one- or two-sided testing, or both; 8) inspection complexity. Note that the analysis of the relationship between true lateral sizes of defects and their surface “footprints” by means of each

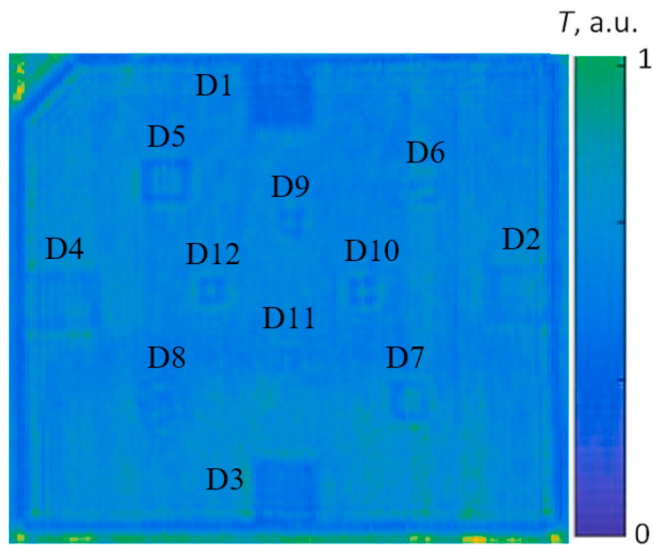


Fig. 12. Terahertz line-scanning results.

used NDT technique has been beyond the scope of this research. It is supposed that the transmission Terahertz technique may provide the most clear defect indications, but TNDT procedures accompanied by lateral heat diffusion also allow determining defect lateral dimensions with the accuracy better than 10%.

Obviously, the data in Table 2 is subjective, but it illustrates the concept for the test case in this study. It is recognized that a high inspection rate is a great advantage of TNDT compared to many other techniques. For example, according to Table 2, the highest inspection rate ($2.11 \text{ m}^2 \text{ h}^{-1}$) is achieved by a line-scanning procedure using halogen lamps, and this technique provides reasonable performance based on other performance parameters. Note that THz imaging is a relatively new NDT method, and one may expect its performance to improve in the near future.

6. Conclusion

This study has illustrated the potentials of optical and THz inspection in the identification of inserts of different nature in GFRP composite. The efficiency of five inspection procedures has been comparatively evaluated by applying the Tanimoto criterion which combines missed and false defects. With the highest possible value of this criterion equal to 100%, the best test procedure has been one-sided “stationary” TNDT

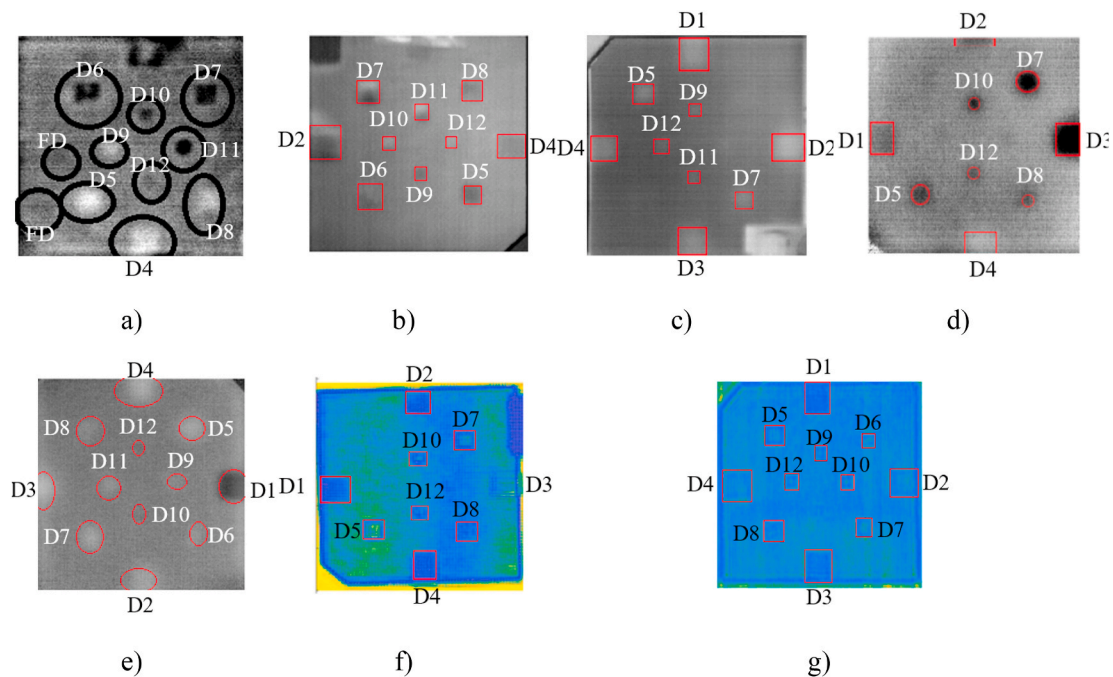


Fig. 13. Analyzing test results by Tanimoto criterion: a - optical stationary heating, one-sided procedure, front surface, TSR, 1st derivative (Fig. 3b), b - optical line-scanning heating, front surface (Fig. 4c), c - optical line-scanning heating, rear surface (Fig. 4d) d - flash heating, front surface, TSR, 1st derivative (Fig. 6b), e – flash heating, rear surface, TSR, 1st derivative (Fig. 6d), f - THz point-by-point scanning, Fig. 11a, g - THz line-scanning, Fig. 12.

Table 1
Test results by Tanimoto criterion.

Image	Optical stationary heating, one-sided procedure, front surface, TSR, 1st derivative (Fig. 3b)	Optical line-scanning heating, front surface, (Fig. 4c)	Optical line-scanning heating, rear surface (Fig. 4d)	Flash heating, front surface, TSR, 1st derivative (Fig. 6b)	Flash heating, rear surface, TSR, 1st derivative (Fig. 6d)	THz point-by-point scanning, Fig. 11a	THz line-scanning, Fig. 12
$N_{c,d}$ ^a	9,9	10,4	9	8,9	10,4	8,7	9,8
$N_{m,d}$	2,1	1,6	3	3,1	1,6	3,3	2,2
$N_{f,d}$	0,5	0,1	0	0,2	0	0,1	0
$TC \pm \sigma$ ^b	$0,80 \pm 0,09$	$0,86 \pm 0,05$	$0,75 \pm 0,11$	$0,73 \pm 0,08$	$0,87 \pm 0,10$	$0,72 \pm 0,08$	$0,82 \pm 0,19$

^a $N_{c,d}$ is the number of true defects correctly identified by a respondent ($N_{c,d} = N_r - N_{m,d}$).

^b σ is the standard deviation of TC values determined by 10 respondents.

Table 2
Evaluating performance of TNDT and THz NDT test results.

Performance parameter	Test method				
	Optical stationary heating (halogen lamps)	Optical heating (line scanning, halogen lamps)	Optical stationary heating (Xenon lamps)	THz technique (point-by-point scanning)	THz technique (line scanning)
Tanimoto criterion	0.80	0.86	0.87	0.72	0.82
Inspection rate, m ² hr ⁻¹	0.76	2.11	0.76	0.0048	7.61
Ability to characterize defect size/depth/thickness	+ / + / +	+ ^a / + ^a / +	+ / + / +	+ / - / +	+ / - / +
Ability to detect insert material	+	+	+	+ ^b	+ ^b
Minimal detectable defect size, mm	10 × 10	10 × 10	10 × 10	10 × 10	10 × 10
Unit test area, mm	350 × 350	300 × 100	300 × 300	4 × 4	300 × 30
Suitability for one- and two-sided testing	+ / +	+ / +	+ / +	- ^c / +	- ^c / +
Inspection complexity	Low	Medium	Low	High	Low

^a By using neural network.

^b By calculating attenuation coefficient.

^c Except a one-sided procedure where a reflector is placed behind a test sample.

implementing optical heating with Xenon lamps (Tanimoto criterion value 87%). Close values of the Tanimoto criterion have been achieved by using the optical and THz line-scanning procedures. A more subjective evaluation of test procedures has been performed by comparing eight parameters of test performance. From this point of view, a line-scanning TNDT procedure implementing optical heating with halogen lamps has seemed to be optimal in practical applications. THz imaging is a relatively novel NDT method. It is promising in the inspection of GFRP due to high transparency of this composite toward THz radiation, and one may expect its performance to improve in the near future.

CRedit authorship contribution statement

A.O. Chulkov: Conceptualization, Investigation, Writing - original draft, Writing - review & editing. **A. Sommier:** Investigation, Software. **C. Pradere:** Methodology, Validation, Resources. **V.P. Vavilov:** Methodology, Writing - original draft, Writing - review & editing, Formal analysis, Project administration. **A.O. Siddiqui:** Resources, Writing - review & editing. **Y.L.V.D. Prasad:** Resources, Project administration.

Declaration of competing interest

The authors declare that they have no known competing financial interests or personal relationships that could have appeared to influence the work reported in this paper.

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Appendix A. Supplementary data

Supplementary data to this article can be found online at <https://doi.org/10.1016/j.ndteint.2020.102383>.

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